

M5M5W816TP-70HI, 85HI

PRELIMINARY

Notice: This is not a final specification.
Some parametric limits are subject to change

8388608-BIT (524288-WORD BY 16-BIT) CMOS STATIC RAM

Those are summarized in the part name table below.

DESCRIPTION

The M5M5W816TP is a family of low voltage 8-Mbit static RAMs organized as 524288-words by 16-bit, fabricated by Mitsubishi's high-performance 0.18μm CMOS technology.

The M5M5W816TP is suitable for memory applications where a simple interfacing, battery operating and battery backup are the important design objectives.

The M5M5W816TP is packaged in a 44pin thin small outline mount device, with the outline of 400mil TSOP TYPE(II). It gives the best solution for a compaction of mounting area as well as flexibility of wiring pattern of printed circuit boards.

The operating temperature range is -40~+85°C

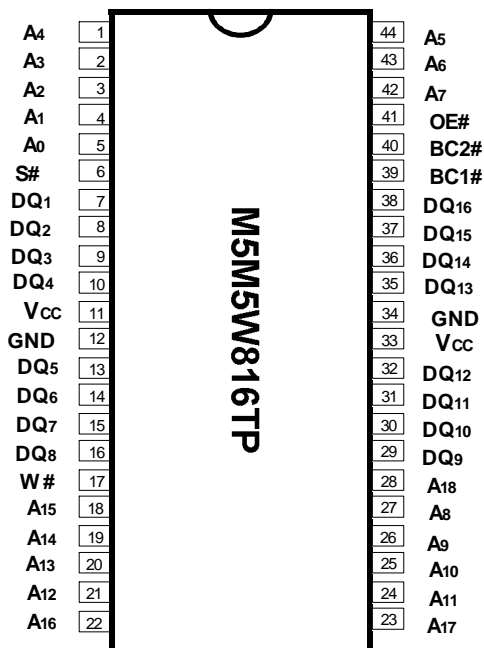
FEATURES

- Single 2.7~3.0V power supply
- Small stand-by current: 0.2μA (3.0V, typ.)
- No clocks, No refresh
- Data retention supply voltage =2.0V
- All inputs and outputs are TTL compatible.
- Easy memory expansion by S#, BC1# and BC2#
- Common Data I/O
- Three-state outputs: OR-tie capability
- OE# prevents data contention in the I/O bus
- Process technology: 0.18μm CMOS
- Package: 44pin 400mil TSOP TYPE(II)

Version, Operating temperature	Part name	Power Supply	Access time max.	Stand-by current						Active current I _{cc1} *(typ.)
				* Typical		Ratings (max.)				
				25°C	40°C	25°C	40°C	70°C	85°C	
I-version -40~+85°C	M5M5W816TP -70HI	2.7~3.0V	70ns	0.5	1.0	2	4	20	40	40mA (10MHz) 5mA (1MHz)
	M5M5W816TP -85HI		85ns							

* Typical parameter indicates the value for the center of distribution, and not 100% tested.

PIN CONFIGURATION



44Pin 400mil TSOP
Outline: 44P3W
NC: No Connection

Pin	Function
A0 ~ A18	Address input
DQ1 ~ DQ16	Data input / output
S#	Chip select input
W#	Write control input
OE#	Output enable input
BC1#	Lower Byte (DQ1 ~ 8)
BC2#	Upper Byte (DQ9 ~ 16)
Vcc	Power supply
GND	Ground supply



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FUNCTION

The M5M5W816TP is organized as 524288-words by 16-bit. These devices operate on a single +2.7~3.0V power supply, and are directly TTL compatible to both input and output. Its fully static circuit needs no clocks and no refresh, and makes it useful.

The operation mode are determined by a combination of the device control inputs BC1# , BC2# , S# , W# and OE#. Each mode is summarized in the function table.

A write operation is executed whenever the low level W# overlaps with the low level BC1# and/or BC2# and the low level S#. The address(A0~A18) must be set up before the write cycle and must be stable during the entire cycle.

A read operation is executed by setting W# at a high level and OE# at a low level while BC1# and/or BC2# and S# are in an active state(S#=L).

When setting BC1# at the high level and other pins are in an active stage , upper-byte are in a selectable mode in which both reading and writing are enabled, and lower-byte are in a non-selectable mode. And when setting BC2# at a high level and other pins are in an active stage, lower-byte are in a selectable mode and upper-byte are in a non-selectable mode.

The operating temperature range is -40 ~ +85°C

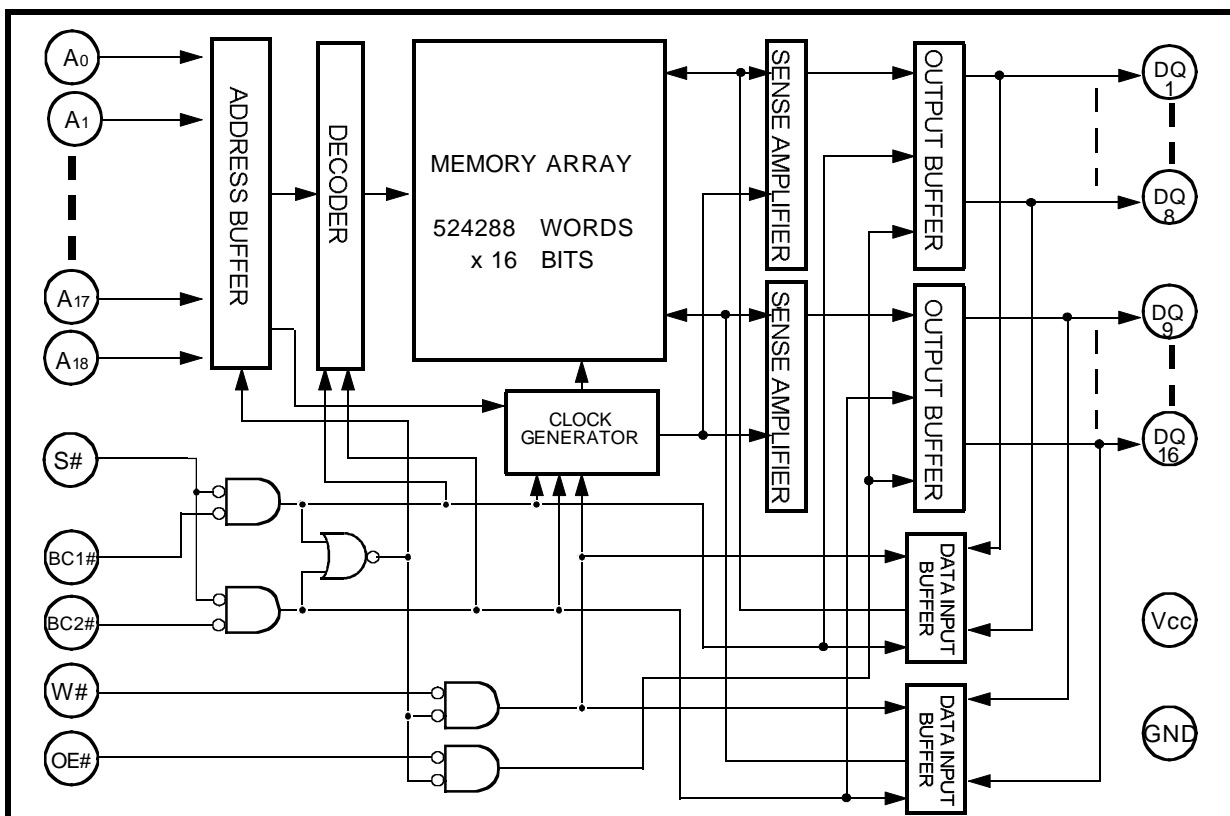
When setting BC1# and BC2# at a high level or S# at a high level, the chips are in a non-selectable mode in which both reading and writing are disabled. In this mode, the output stage is in a high-impedance state, allowing OR-tie with other chips and memory expansion by BC1#, BC2# and S#.

The power supply current is reduced as low as 0.1µA(25°C, typical), and the memory data can be held at +2.0V power supply, enabling battery back-up operation during power failure or power-down operation in the non-selected mode.

FUNCTION TABLE

S#	BC1#	BC2#	W#	OE#	Mode	DQ1~8	DQ9~16	I _{cc}
H	X	X	X	X	Non selection	High-Z	High-Z	Standby
X	H	H	X	X	Non selection	High-Z	High-Z	Standby
L	L	H	L	X	Write	Din	High-Z	Active
L	L	H	H	L	Read	Dout	High-Z	Active
L	L	H	H	H	————	High-Z	High-Z	Active
L	H	L	L	X	Write	High-Z	Din	Active
L	H	L	H	L	Read	High-Z	Dout	Active
L	H	L	H	H	————	High-Z	High-Z	Active
L	L	L	L	X	Write	Din	Din	Active
L	L	L	H	L	Read	Dout	Dout	Active
L	L	L	H	H	————	High-Z	High-Z	Active

BLOCK DIAGRAM



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Symbol	Parameter	Conditions	Ratings	Units
V _{CC}	Supply voltage	With respect to GND	-0.3* ~ +4.6	V
V _I	Input voltage	With respect to GND	-0.3* ~ V _{CC} + 0.3 (max. 4.6V)	
V _O	Output voltage	With respect to GND	0 ~ V _{CC}	
P _d	Power dissipation	T _a = 25°C	700	mW
T _a	Operating temperature		- 40 ~ +85	°C
T _{stg}	Storage temperature		- 65 ~ +150	°C

* -3.0V in case of AC (Pulse width ≤ 30ns)

DC ELECTRICAL CHARACTERISTICS(V_{CC}=2.7 ~ 3.0V, unless otherwise noted)

Symbol	Parameter	Conditions	Limits			Units	
			Min	Typ	Max		
V _{IH}	High-level input voltage		2.2		V _{CC} +0.2V	V	
V _{IL}	Low-level input voltage		-0.2 *		0.6		
V _{OH}	High-level output voltage	I _{OH} = - 0.5mA	2.4				
V _{OL}	Low-level output voltage	I _{OL} =2mA			0.4		
I _I	Input leakage current	V _I =0 ~ V _{CC}			±1	μA	
I _O	Output leakage current	BC1# and BC2#=V _{IH} or S#=V _{IH} or OE#=V _{IH} , V _{I/O} =0 ~ V _{CC}			±1	μA	
I _{CC1}	Active supply current (AC, MOS level)	BC1# and BC2# ≤ 0.2V, S# ≤ 0.2V other inputs ≤ 0.2V or ≥ V _{CC} -0.2V Output - open (duty 100%)	f = 10MHz	-	30	40	mA
			f = 1MHz	-	5	10	
I _{CC2}	Active supply current (AC, TTL level)	BC1# and BC2#=V _{IL} , S#=V _{IL} other pins =V _{IH} or V _{IL} Output - open (duty 100%)	f = 10MHz	-	30	40	mA
			f = 1MHz	-	5	10	
I _{CC3}	Stand by supply current (AC, MOS level)	(1) S# ≥ V _{CC} - 0.2V, other inputs = 0 ~ V _{CC}	~ +25°C	-	0.5	2	μA
			~ +40°C	-	1.0	4	
			~ +70°C	-	-	20	
			~ +85°C	-	-	40	
I _{CC4}	Stand by supply current (AC, TTL level)	BC1# and BC2#=V _{IH} or S#=V _{IH} Other inputs= 0 ~ V _{CC}	-	-	2	mA	

Note 1: Direction for current flowing into IC is indicated as positive (no mark)

* -3.0V in case of AC (Pulse width ≤ 30ns)

Note 2: Typical parameter indicates the value for the center of distribution at 3.0V, and not 100% tested.

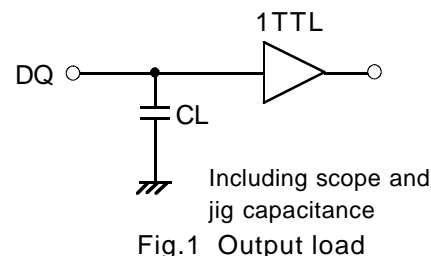
CAPACITANCE(V_{CC}=2.7 ~3.0V, unless otherwise noted)

Symbol	Parameter	Conditions	Limits			Units
			Min	Typ	Max	
C _I	Input capacitance	V _I =GND, V _I =25mVrms, f=1MHz			10	pF
C _O	Output capacitance	V _O =GND, V _O =25mVrms, f=1MHz			10	



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Supply voltage	2.7~3.0V
Input pulse	$V_{IH}=2.4V$, $V_{IL}=0.4V$
Input rise time and fall time	5ns
Reference level	$V_{OH}=V_{OL}=1.5V$ Transition is measured $\pm 200mV$ from steady state voltage.(for t_{en}, t_{dis})
Output loads	Fig.1, $CL=30pF$ $CL=5pF$ (for t_{en}, t_{dis})

**(2) READ CYCLE**

Symbol	Parameter	Limits				Units
		70HI		85HI		
		Min	Max	Min	Max	
t_{CR}	Read cycle time	70		85		ns
$t_{a(A)}$	Address access time		70		85	ns
$t_{a(S)}$	Chip select 1 access time		70		85	ns
$t_{a(BC1)}$	Byte control 1 access time		70		85	ns
$t_{a(BC2)}$	Byte control 2 access time		70		85	ns
$t_{a(OE)}$	Output enable access time		35		45	ns
$t_{dis(S)}$	Output disable time after S# high		25		30	ns
$t_{dis(BC1)}$	Output disable time after BC1# high		25		30	ns
$t_{dis(BC2)}$	Output disable time after BC2# high		25		30	ns
$t_{dis(OE)}$	Output disable time after OE# high		25		30	ns
$t_{en(S)}$	Output enable time after S# low	10		10		ns
$t_{en(BC1,2)}$	Output enable time after BC1#, BC2# low	5		5		ns
$t_{en(OE)}$	Output enable time after OE# low	5		5		ns
$t_{v(A)}$	Data valid time after address	10		10		ns

*5ns in case of using either BC1# or BC2#

(3) WRITE CYCLE

Symbol	Parameter	Limits				Units
		70HI		85HI		
		Min	Max	Min	Max	
t_{CW}	Write cycle time	70		85		ns
$t_{w(W)}$	Write pulse width	55		60		ns
$t_{su(A)}$	Address setup time	0		0		ns
$t_{su(A-WH)}$	Address setup time with respect to W#	65		70		ns
$t_{su(BC1)}$	Byte control 1 setup time	65		70		ns
$t_{su(BC2)}$	Byte control 2 setup time	65		70		ns
$t_{su(S)}$	Chip select setup time	65		70		ns
$t_{su(D)}$	Data setup time	35		45		ns
$t_{h(D)}$	Data hold time	0		0		ns
$t_{rec(W)}$	Write recovery time	0		0		ns
$t_{dis(W)}$	Output disable time from W# low		25		30	ns
$t_{dis(OE)}$	Output disable time from OE# high		25		30	ns
$t_{en(W)}$	Output enable time from W# high	5		5		ns
$t_{en(OE)}$	Output enable time from OE# low	5		5		ns



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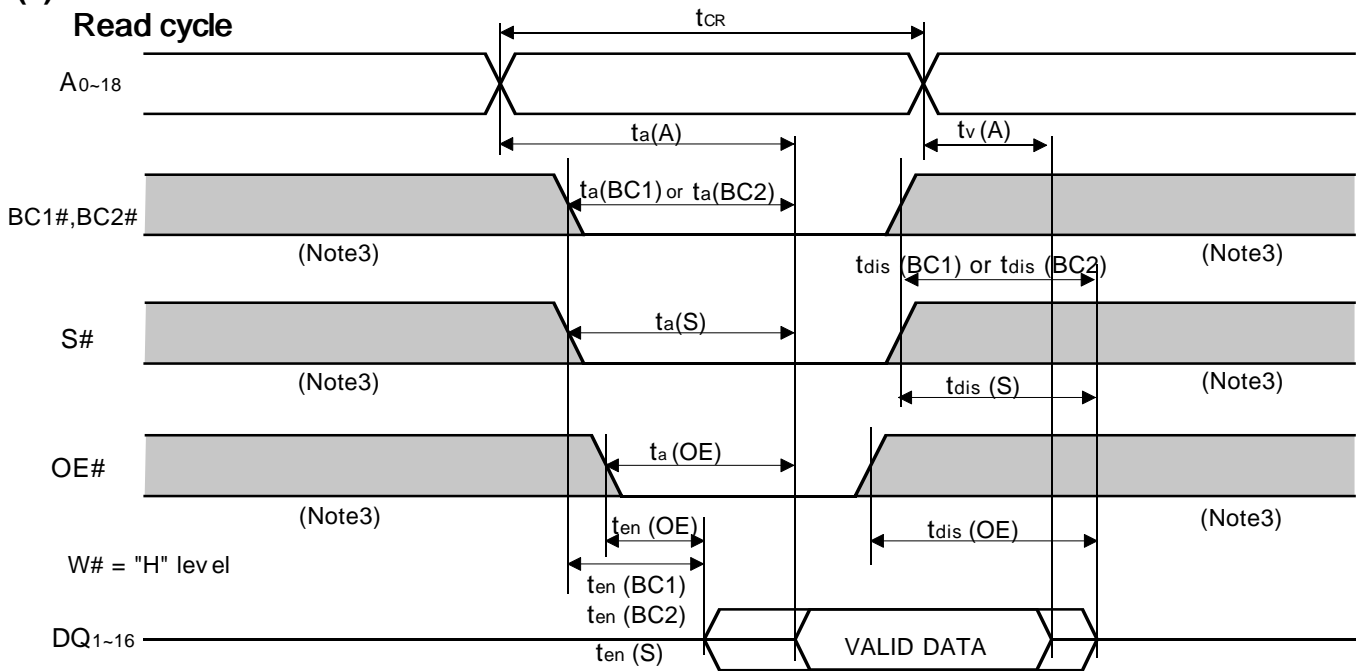
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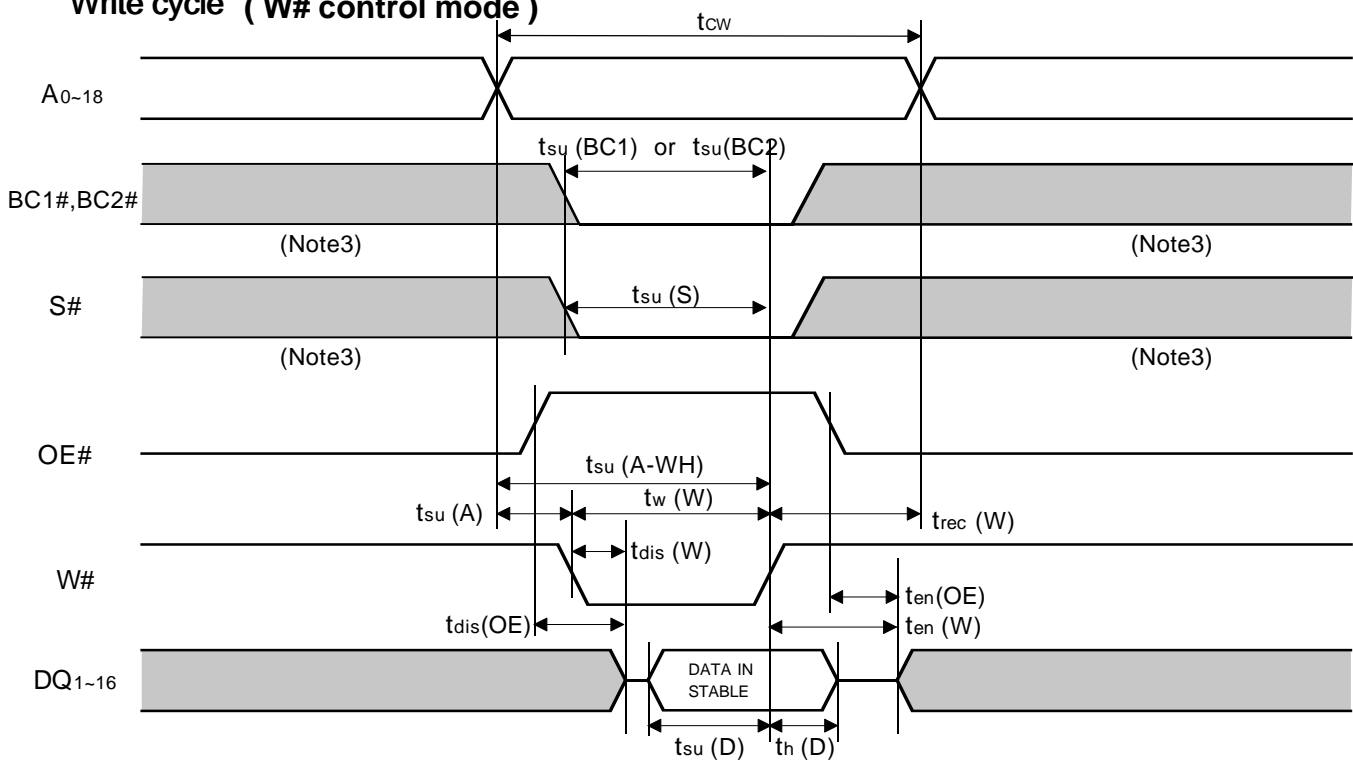
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(4)TIMING DIAGRAMS

Read cycle



Write cycle (W# control mode)

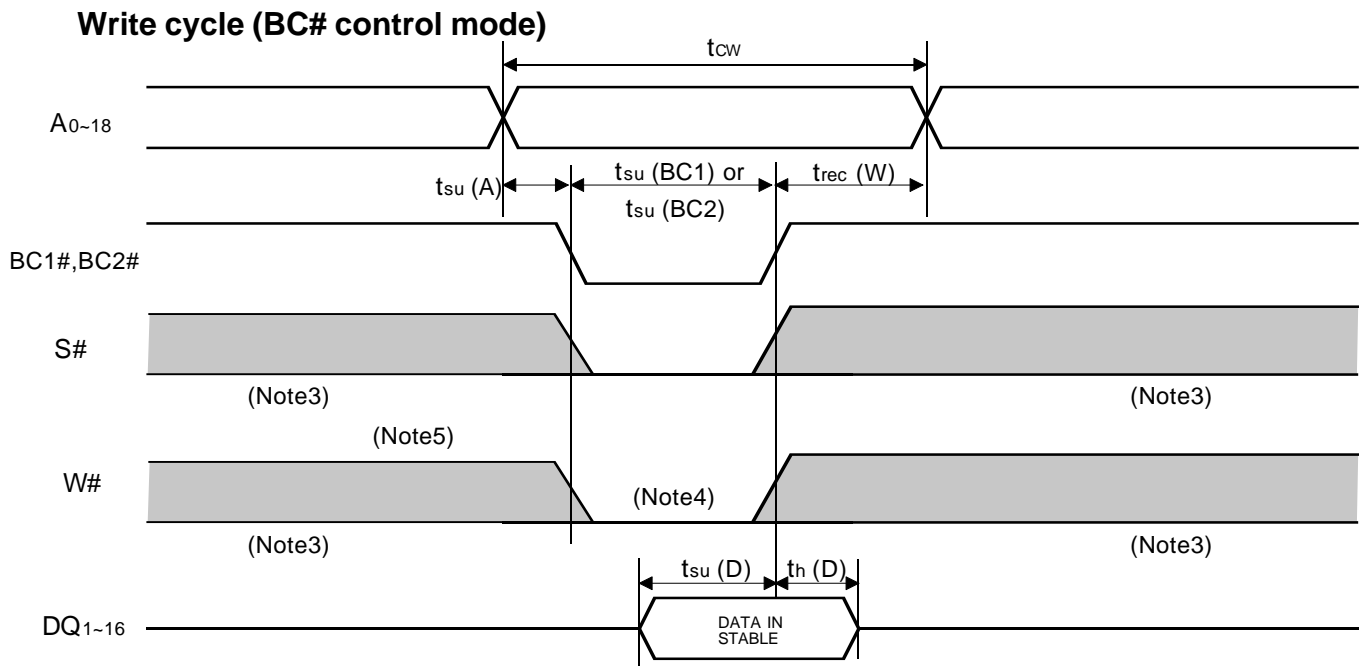


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Note 3: Hatching indicates the state is "don't care".

Note 4: A Write occurs during S# low overlaps BC1# and/or BC2# low and W# low.

Note 5: When the falling edge of W# is simultaneously or prior to the falling edge of BC1# and/or BC2# or the falling edge of S#, the outputs are maintained in the high impedance state.

Note 6: Don't apply inverted phase signal externally when DQ pin is in output mode.



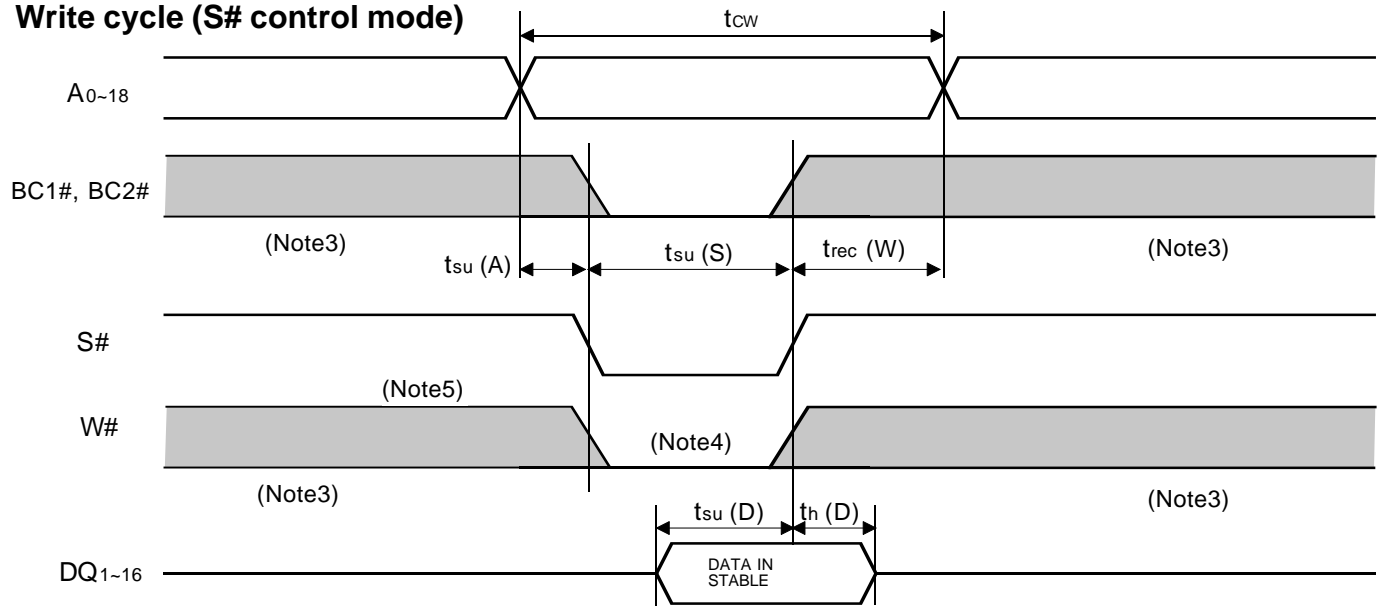
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Write cycle (S# control mode)

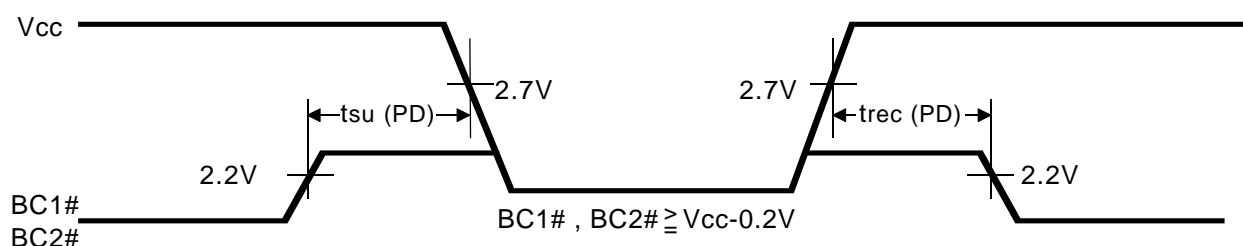
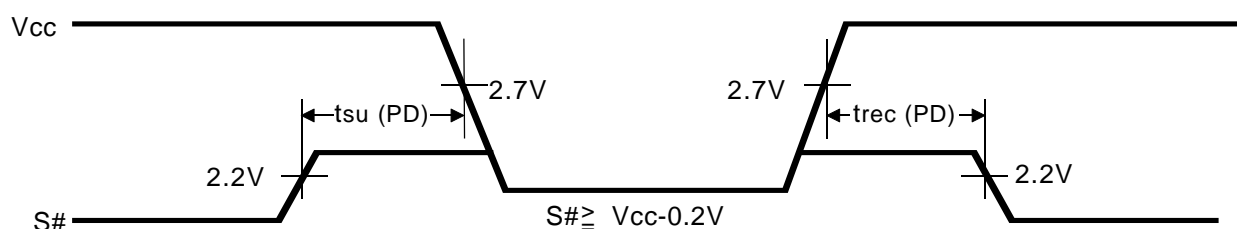


M5M5W816TP-70HI, 85HI**PRELIMINARY**Notice: This is not a final specification.
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Symbol	Parameter	Test conditions	Limits			Units	
			Min	Typ	Max		
V _{CC} (PD)	Power down supply voltage		2.0			V	
V _I (BC)	Byte control input BC1# & BC2#		2.0			V	
V _I (S)	Chip select input S#		2.0			V	
I _{CC} (PD)	Power down supply current	V _{CC} =2.0V (1) S# ≥ V _{CC} - 0.2V, other inputs = 0 ~ V _{CC} (2) BC1# and BC2# ≥ V _{CC} - 0.2V S# ≤ 0.2V other inputs = 0 ~ V _{CC}	~ +25°C	-	0.1	1.5	μA
			~ +40°C	-	0.2	3	
			~ +70°C	-	-	15	
			~ +85°C	-	-	30	

Note 2: Typical parameter of I_{CC}(PD) indicates the value for the center of distribution at 2.0V, and not 100% tested.**(2) TIMING REQUIREMENTS**

Symbol	Parameter	Test conditions	Limits			Units
			Min	Typ	Max	
t _{su} (PD)	Power down set up time		0			ns
t _{rec} (PD)	Power down recovery time		5			ms

(3) TIMING DIAGRAM**BC# control mode****S# control mode**

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